

**PATENT** 

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of : Customer Number: 20277

Wataru ITOH, et al. : Confirmation Number: 3512

Serial No.: 10/637,663 : Group Art Unit: 1732

Filed: August 11, 2003 : Examiner: not yet assigned

For: ASSEMBLY FOR LSI TEST AND METHOD FOR THE TEST

## INFORMATION DISCLOSURE STATEMENT

Mail Stop Information Disclosure Statement Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Dear Sir:

In accordance with the provisions of 37 C.F.R. 1.56, 1.97 and 1.98, the attention of the Patent and Trademark Office is hereby directed to the references listed on the attached form PTO-1449. It is respectfully requested that the references be expressly considered during the prosecution of this application, and that the references be made of record therein and appear among the "References Cited" on any patent to issue therefrom.

This Information Disclosure Statement is being filed within three months of the U.S. filing date OR before the mailing date of a first Office Action on the merits. No certification or fee is required.

Each non-English language reference was first cited in a corresponding foreign application search report or office action and its relevance discussed therein. A copy of the

## 10/637,663

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foreign search report or office action, together with an English language version thereof, is attached for the Examiner's information.

Please charge any shortage in fees due in connection with the filing of this paper, including extension of time fees, to Deposit Account 500417 and please credit any excess fees to such deposit account.

Respectfully submitted,

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Date: July 7, 2004

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			APPLICANT Wataru ITOH, et al.						
(PTO-1449)				FILING DATE GROUP 1732					
				U.S. PATEN	T DOCUMENTS	•			
EXAMINER'S INITIALS	CITE NO.	Document Number Number-Kind Code2 (il known)		Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document		Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear		
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EXAMINER'S		Fo	reign Patent Document	Publication Date	Name of Patentee or	Pages, Colu	mns, Lines	Tra	anslation
INITIALS CITE		Country Codes -Number 4 -Kind Codes (if known)		MM-DD-YYYY	Applicant of Cited Document	Where Relevant Figures Appear			
		۲.	JP 04155278 English abstract	05/28/1992	NEC Corp.			Yes	No
	A2	1	WO 02/29824	04/11/2002	Concord Idea Corp.				Ŷ
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		HERMANN A L: "Diagnostic Data Comparator" IBM Technical Disclose Bulletin, IBM Corp. New York, US, vol. 24, no. 5, 1 October 1981, pages 2591-2592, XP000713903, ISSN: 0018-8689 *the whole document*							
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EXAMINER				DATE CONSIDERED					

<sup>\*</sup>EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

1 Applicant's unique citation designation number (optional). 2 Applicant is to place a check mark here if English language Translation is attached.